TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOSVI-H)

TPC8035-H

High Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

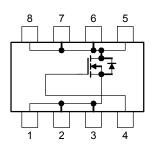
- Small footprint due to small and thin package
- High-speed switching
- Small gate charge: Qsw = 17 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) = $2.3 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 70 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 10 \mu A \text{ (max) (V}_{DS} = 30 \text{ V)}$
- Enhancement mode: $V_{th} = 1.3 \text{ to } 2.3 \text{ V (VDS} = 10 \text{ V, ID} = 1 \text{ mA)}$

Absolute Maximum Ratings (Ta = 25°C)

Characte	eristic	Symbol	Rating	Unit	
Drain-source voltage	ain-source voltage		30	V	
Drain-gate voltage (R	GS = 20 kΩ)	V_{DGR}	30	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	ID	18	Α	
Diam current	Pulsed (Note 1)	I_{DP}	72		
Drain power dissipation	on $(t = 10 s)$ (Note 2a)	P_{D}	1.9	W	
Drain power dissipation	on (t = 10 s) (Note 2b)	P_{D}	1.0	W	
Single pulse avalanch	ne energy (Note 3)	E _{AS}	211	mJ	
Avalanche current		I _{AR}	18	Α	
Repetitive avalanche	energy Note 2a) (Note 4)	E _{AR}	0.082	mJ	
Channel temperature	Channel temperature		150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	

Weight: 0.085 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

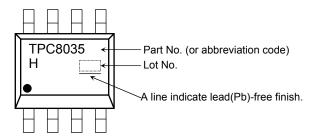
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating" Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Thermal Characteristics

Characteristic	Symbol	Max	Unit
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a)	R _{th (ch-a)}	65.8	°C/W
Thermal resistance, channel to ambient $(t=10 \; s) \eqno (Note \; 2b)$	R _{th (ch-a)}	125	°C/W

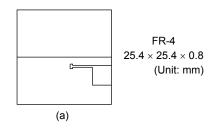
Marking (Note 5)

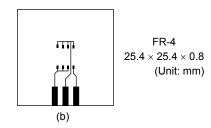


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)

(b) Device mounted on a glass-epoxy board (b)



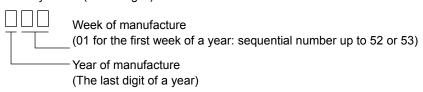


Note 3: $V_{DD}=24~V,~T_{ch}=25^{\circ}C$ (initial), $L=500~\mu H,~R_{G}=25~\Omega,~I_{AR}=18~A$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)



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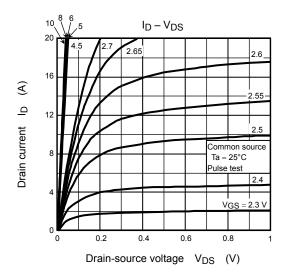
Electrical Characteristics (Ta = 25°C)

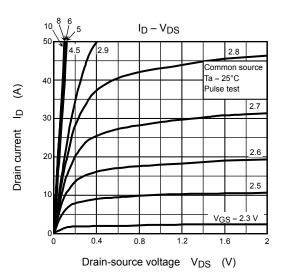
Characteristic		Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage current		I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cut-OFF cu	ain cut-OFF current		V _{DS} = 30 V, V _{GS} = 0 V		_	10	μА
Drain agurag bro	akdawa valtaga	V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_	_	V
Drain-source breakdown voltage Gate threshold voltage		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15	_	_	v
Gate threshold vo	oltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.3	_	2.3	V
Drain source ON	rosistanco	Pro (out)	V _{GS} = 4.5 V, I _D = 9 A	_	2.6	3.6	0
Drain-source ON-resistance		R _{DS} (ON)	V _{GS} = 10 V, I _D = 9 A	_	2.3	3.2	mΩ
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 9 A	35	70	_	S
Input capacitance	e	C _{iss}		_	6000	7800	pF
Reverse transfer	capacitance	C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	380	610	
Output capacitan	ce	C _{oss}			1100		
Gate resistance		rg	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	1.0	1.5	Ω
Switching time	Rise time	t _r	V _{GS} 10 V	_	5.1	_	ns
	Turn-ON time	t _{on}		_	16	_	
	Fall time	t _f		_	11	_	
	Turn-OFF time	t _{off}	V _{DD} ≈ 15 V Duty ≤ 1%, t _W = 10 μs	_	69	_	
Total gate charge			$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$	_	82	_	
(gate-source plus	gate-drain)	Qg	$V_{DD} \approx 24 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 18 \text{ A}$	_ 44			
Gate-source charge 1		Q _{gs1}		_	14	_	nC
Gate-drain ("miller") charge		Q _{gd}	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 18 \text{ A}$	_	13	_	
Gate switch char	ge	Q _{SW}	1	_	17	_	

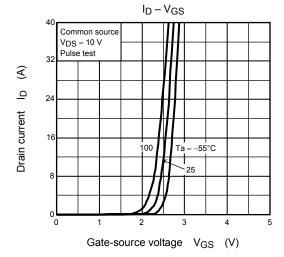
Source-Drain Ratings and Characteristics (Ta = 25°C)

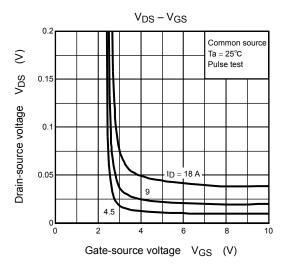
Characteris	stics		Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse	(Note 1)	I _{DRP}	_	_	_	72	Α
Forward voltage (diode)			V_{DSF}	$I_{DR} = 18 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.2	V

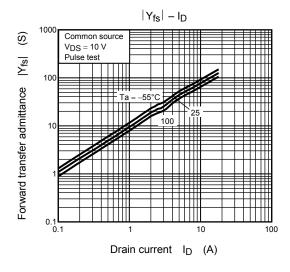
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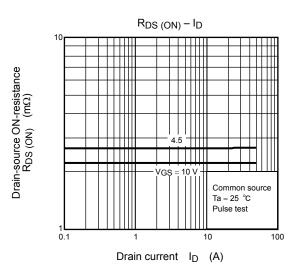




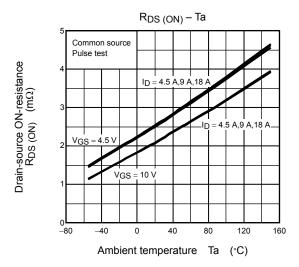


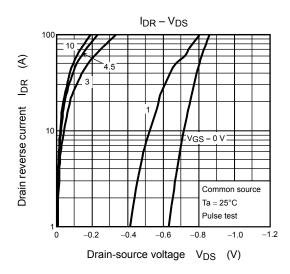


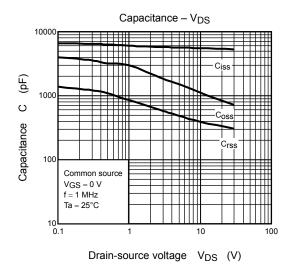


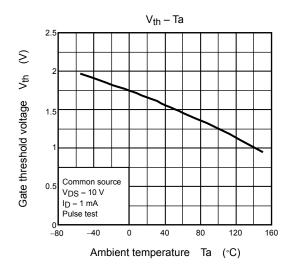


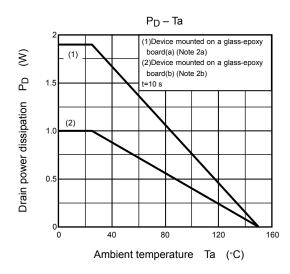
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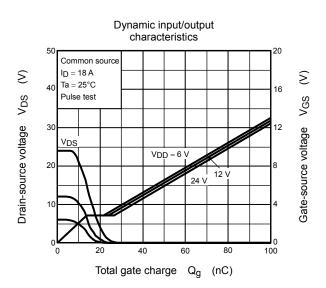


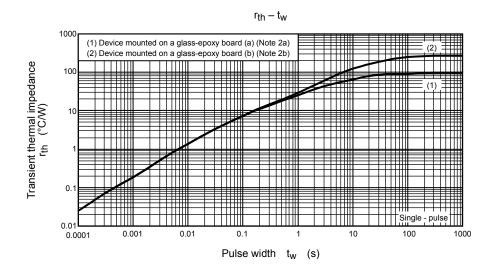


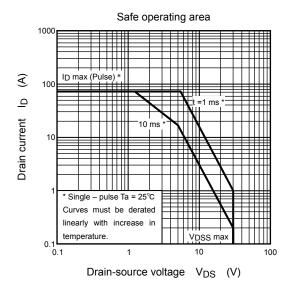












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